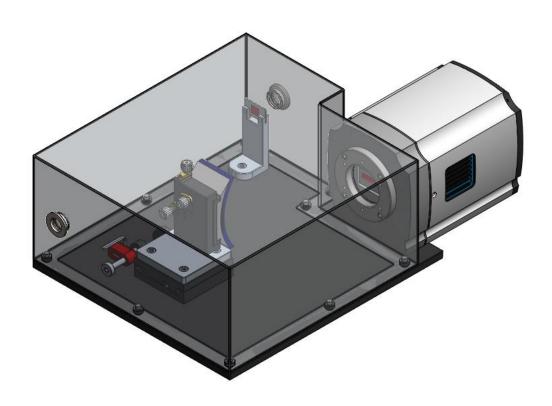


## TENDER X-RAY SPECTROMETER





## **Features**

Diagnostic operation mode

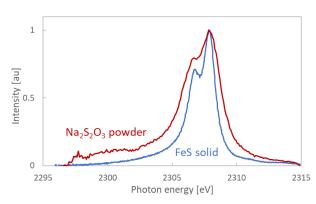
- online beam characterization at HHG beamlines, X-ray freeelectron lasers, table-top X-ray lasers
- non-interfering architecture with backscattering probe
- high transmission >90%

XES operation mode

- emission spectroscopy in the tender X-ray range 2-4keV
- integrated sample mount
- high energy resolution of 10-4 in a bandwidth of 2%

## Versatility

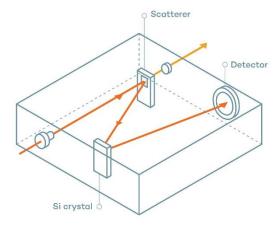
- small footprint
- easily transferred between experimental stations
- intuitive operation



X-ray absorption spectroscopy (XAS) at the sulfur K-edge

The tender X-ray range provides sensitive access to the chemical state of many materials, e.g. investigations of sulfur at 2keV allow for important insights for battery research

(data courtesy of Dr. W. Malzer, TU Berlin)



Operation modes of hardLIGHT: non-interfering online beam characterization by high transmission scattering probe and emission spectroscopy mode



## **Specifications**

Topology von Hamos

Energy range 2-4keV

Source distance flexible

Detector CCD or MCP/CMOS or hybrid

Operating pressure <10<sup>-6</sup>mbar (UHV version available)

Crystal positioning motorized closed-loop

Spectral filter insertion unit optional

Control interfaces USB or Ethernet

Software Windows UI and Labview/VB/C/C++ SDK

Customizable fully customizable

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